


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	09/728,056	ARNAUD, PASCAL	
	<b>Examiner</b>	<b>Art Unit</b>	
	Shengjun Wang	1617	

SEARCHED			
Class	Subclass	Date	Examiner
424	63,64 401	1/6/2006	SW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR